

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/564,444	MEGED, DAVID		
Examiner	Art Unit		
Tejash D. Patel	3765		

	SEARCHED						
Class	Subclass	Date	Examiner				
2	69	1/16/2008	TP				
	81, 93						
	94						
	87	1					
	97						
	272						
	904						
	Dig. 1						
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
PALM Searched		1/16/2008	TP	
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